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Elektromagnetna združljivost (EMC) - 4-29. del: Preskusne in merilne tehnike - Preskusi odpornosti proti upadom napetosti, kratkotrajnim prekinitvam napajanja in odklonom napetosti za enosmerni (DC) napajalni priključek

Electromagnetic compatibility (EMC) - Part 4-29: Testing and measurement techniques - Voltage dips, short interruptions and voltage variations on d.c. input power port immunity tests

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Elektromagnetische Verträglichkeit (EMV) - Teil 4-29: Prüf- und Messverfahren - Prüfungen der Störfestigkeit gegen Spannungseinbrüche, Kurzzeitunterbrechungen und Spannungsschwankungen an Gleichstrom-Netzeingängen

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Ta slovenski standard je istoveten z: **EN IEC 61000-4-29:2026**

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Compatibilité électromagnétique (CEM) - Partie 4-29: Techniques d'essai et de mesure - Creux de tension, coupures brèves et variations de tension sur les accès d'alimentation d'entrée en courant continu (IEC 61000-4-29:2026)

Elektromagnetische Verträglichkeit (EMV) - Teil 4-29: Prüf- und Messverfahren - Prüfungen der Störfestigkeit gegen Spannungseinbrüche, Kurzzeitunterbrechungen und Spannungsschwankungen an Gleichstrom-Netzeingängen (IEC 61000-4-29:2026)

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European foreword

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CONTENTS

FOREWORD 3
INTRODUCTION 5
1 Scope 6
2 Normative references 6
3 Terms, definitions and abbreviated terms 6
3.1 Terms and definitions 6
3.2 Abbreviated terms 7
4 General 7
5 Test levels 8
6 Test generator 12
6.1 General 12
6.2 Characteristics and performances of the generator 13
6.2.1 General 13
6.2.2 Specific characteristics for the generator operating in "low impedance" conditions 13
6.2.3 Specific characteristics for the generator operating in "high impedance" conditions (short interruption) 14
6.3 Verification of the characteristics of the generator 14
6.3.1 General 14
6.3.2 Output voltage and voltage change 14
6.3.3 Switching characteristics 15
6.3.4 Peak inrush current drive capability 15
6.3.5 Output impedance 16
6.3.6 Test level duration 16
7 Test set-up 16
8 Test procedure 16
8.1 General 16
8.2 Laboratory reference conditions 16
8.2.1 General 16
8.2.2 Climatic conditions 16
8.2.3 Electromagnetic conditions 17
8.3 Execution of the test 17
8.3.1 General 17
8.3.2 Voltage dips and short interruptions 17
8.3.3 Voltage variations 17
9 Evaluation of test results 18
10 Test report 18
Annex A (informative) Example of test generators and test set-up 19
Annex B (normative) Inrush current measurement 21
B.1 Test generator peak inrush current drive capability 21
B.2 EUT peak inrush current 21
Annex C (informative) Description of the DC network 23
Bibliography 24

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SIST EN IEC 61000-4-29:2026

Figure 1 – Example of voltage dip 10
Figure 2 – Example of short voltage interruption 11
Figure 3 – Examples of voltage variations 12
Figure A.1 – Example of test generator based on two power sources with switches 19
Figure A.2 – Example of test generator based on a single programmable power supply 20
Figure B.1 – Circuit for measuring the peak inrush current drive capability of a test generator 22
Figure B.2 – Circuit for measuring the peak inrush current of an EUT 22

Table 1 – Preferred test levels and durations for voltage dips 8
Table 2 – Preferred test levels and durations for short voltage interruptions 9
Table 3 – Preferred test levels and durations for voltage variations 9

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